

Traceable metrology as the foundation for reliable SSL performance testing

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Bits&Chips LED Summit 2012

Dutch Metrology Institute



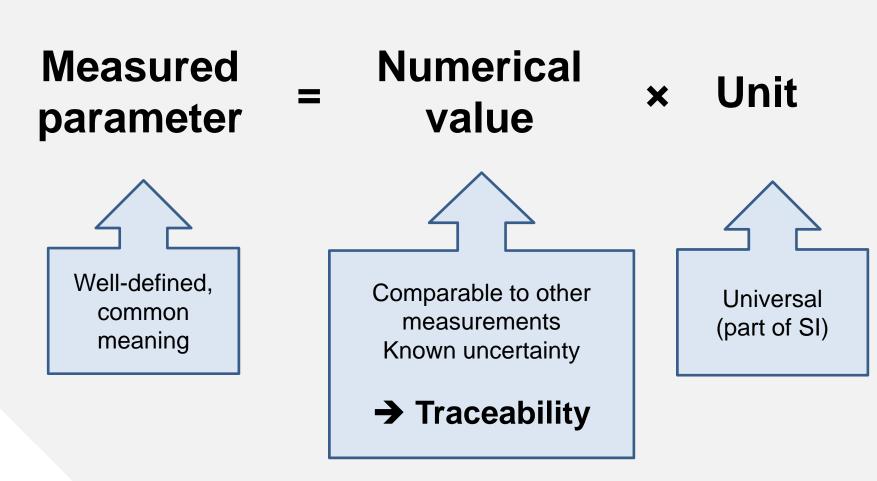
To measure = to know?

- Performance claims should be based on measurements
- But how to guarantee that measurements are reliable?
- SSL more possibilities with respect :
 - Spectral composition
 - Spatial distribution
 - Temporal modulation
- Whereas classical metrology is based on a continuous, isotropical, broadband light source...

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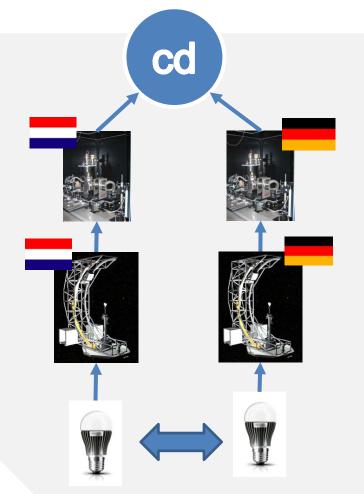
Reliable measurements



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Traceability



- Traceability : unbroken chain of comparisons between object and reference
- Ending at primary standard: realisation of SI unit
- Each comparison has specified uncertainty

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Taking care of traceability



Bureau International des Poids et Mesures



- Global issue: comparible measurements between countries, vital for trade
- Regulated by Metre Convention
- Coordinated by BIPM
- In cooperation with national metrology institutes

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VSL

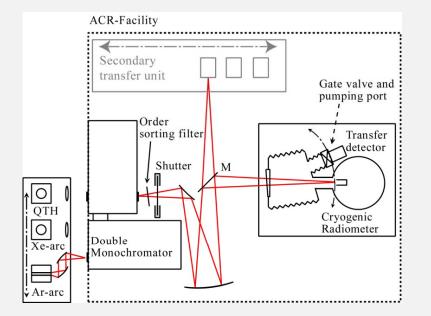


- National metrology institute of the Netherlands
- Maintains national measurement standards
- Represent Netherlands in international metrological infrastructure
- Metrology research
- Provide traceability to customers

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Primary standard for radiometry



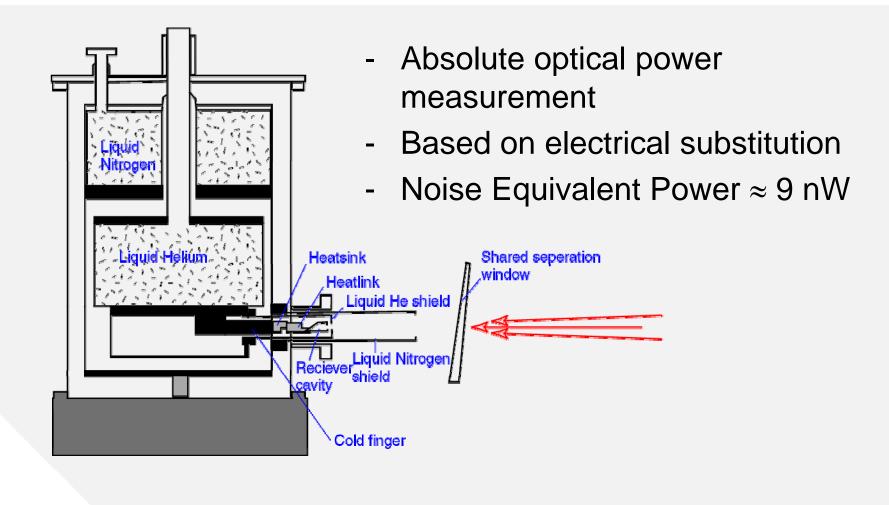


- Provides absolute flux with tunable wavelength
- Wavelength range: 190 nm 20 µm
- Calibration of spectral responsivity of detectors

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Absolute Cryogenic Radiometer

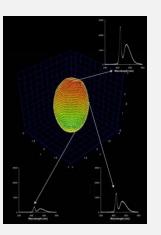


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3D measurement of light sources





- 3m goniometer
 - Movable detector platform
 - Spectrometer and tristimulus meter
- Spatially resolved measurements
- Integrated measurements (virtual integrating sphere)
- Great for SSL!

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Traceable luminous flux

 Traceable measurement of total luminous flux for SSL realised at VSL (ISO 17025 accredited)



Traceability using LED transfer standards



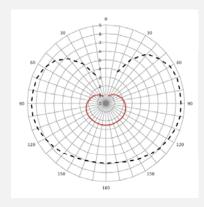
3m virtual integrating sphere (most accurate, spatially resolved)

3m conventional integrating sphere (fastest)

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Successful use





Efficient Electrical End-Use Equipment Infernational Energy Agency

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- Public awareness campaign using off-the-shelf lamps (2009)
 - Real luminous flux 10-30% of suggested luminous flux
 - Power consumption up to 150% of specified value
 - Claimed equivalence 25-40 W; reality << 15W
- Customer measurements
- IEA Annex 4^E European lead (with US, China and Japan)



Extending the possibilities

- Traceability for basic parameters covered:
 - Luminous flux and efficacy
 - Spectrum, color coordinates and color temperature

- But what about:

- Power quality?
- Uncertainty in ray files?
- Color quality indices?
- Pulsed LEDs?
- Environmental influences?
- Lifetime prediction?

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JRP Metrology for SSL



- Goal: traceable metrology for SSL
 - Spatial, spectral and temporal effects
 - Photometric and electrical quantities
 - Human perception aspects
 - General and application-specific
- 17 partners from 14 European countries
- Coordinated by VSL







EMRP





- Combined research program for national metrology institutes
- 50% EU / 50% national funding
- Managed by EURAMET
- Duration : 2009-2016
- Total budget : 400 M€



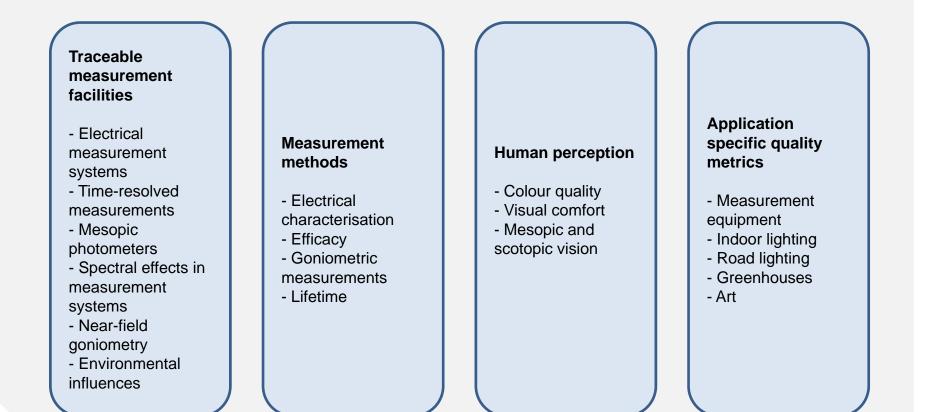


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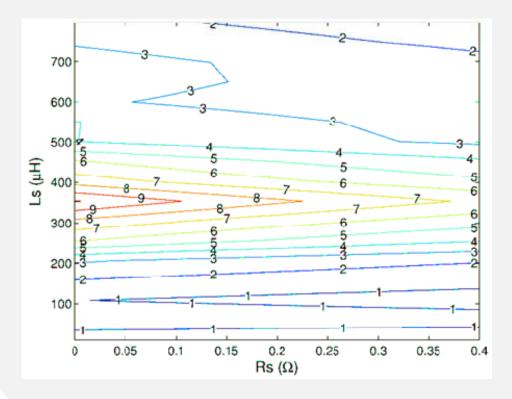
Project pillars





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Contour of the relative deviation (percentage) in RMS current value

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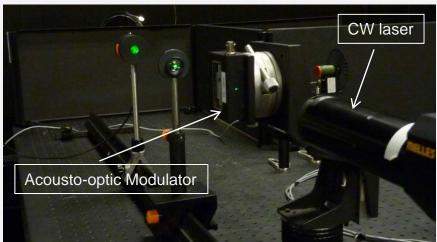
- Source impedance interferes with accurate electrical power measurements
- Solution : specially designed stabilization network
- With stabilisation:
 less than 0.02%
 deviation



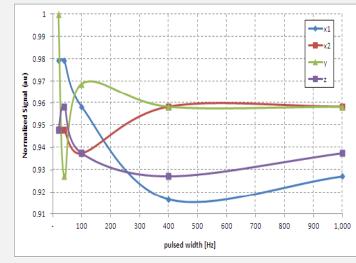


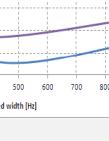
Pulsed LEDs





- Step 1 : calibration of frequency response of tristimulus meter
- Step 2 : measurement of color change in pulsed LED







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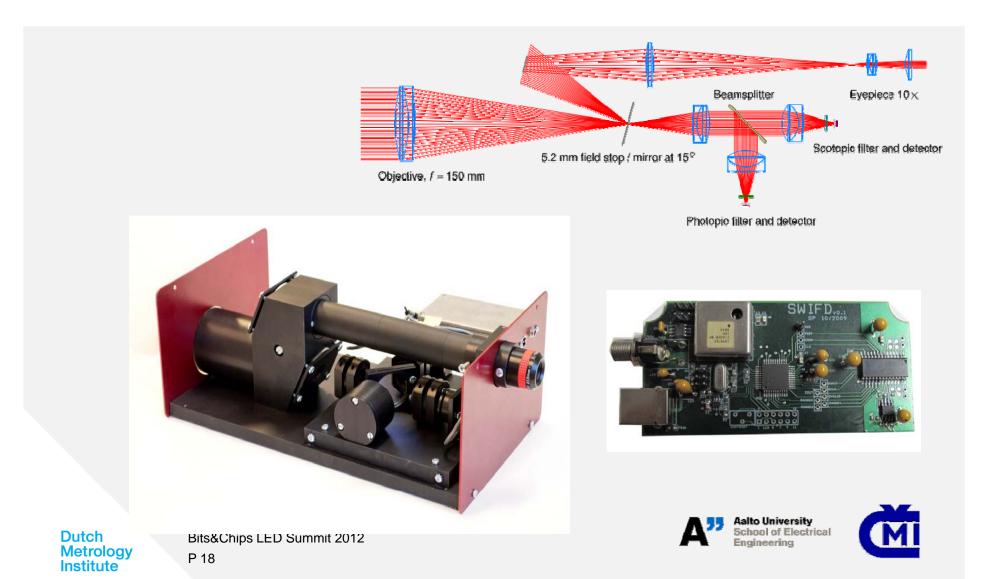
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Mesopic photometer

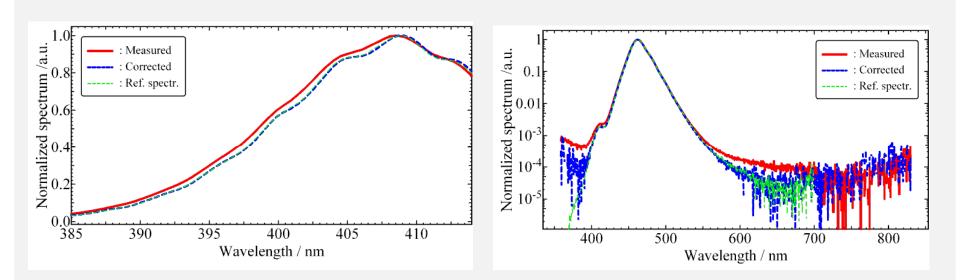






Spectroradiometer calibration





- Measure response of array spectrometer to tunable laser
- Special correction algorithm for band-pass and stray light

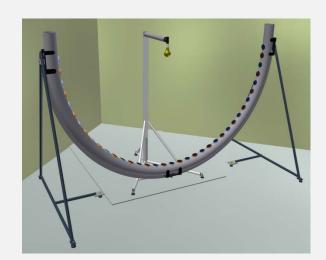
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Fast C-plane profiles

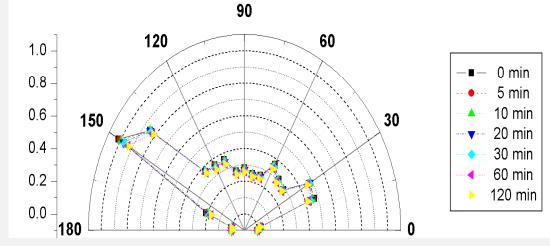






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- Multiple detectors in parallel
- Illumination profile under changing conditions

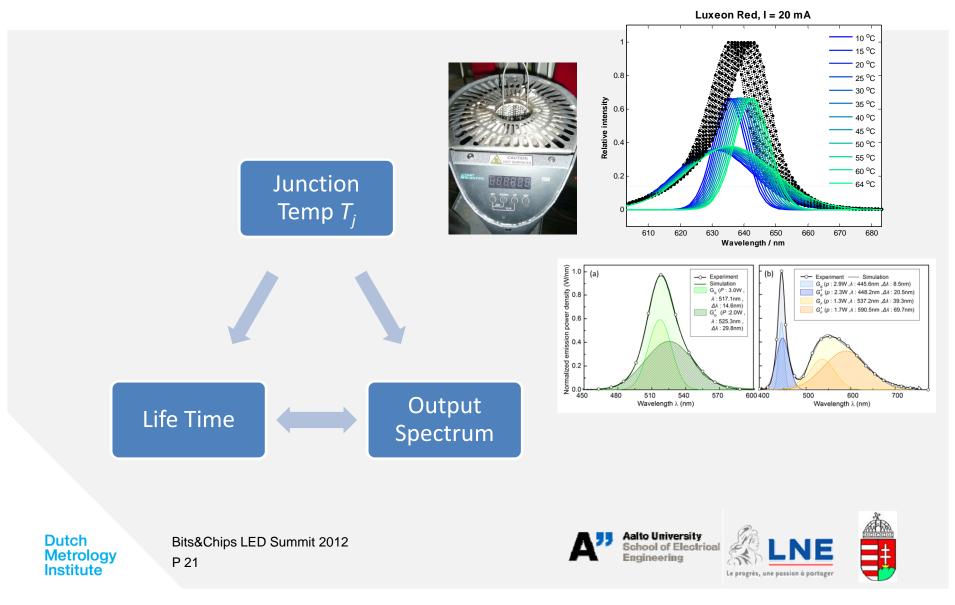






Junction temperature







Human perception





 Comprehensive comparison between various color quality indices and subjective evaluation in specially constructed test room

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Summary



- Reliable SSL characterisation is founded on traceable metrology.
- New traceable metrology needs to be developed to take into account spatial, spectral and temporal properties of SSL.
- EMRP JRP Metrology for SSL combines expertise from European national metrology institutes to realise this.
- Website: <u>http://www.m4ssl.npl.co.uk</u>

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